Search Notes			

•	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/734,740	SHIH ET AL.
	Examiner	Art Unit
	Blessing M. Fubara	1618

	SEARCHED		
Class	Subclass	Date	Examiner
424	486	8/30/2007	BF
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NO (INCLUDING SEARC	OTES H STRATEGY	)
	DATE	EXMR
Reviewed parent application	8/30/2007	BF